

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	
	Amare Mengistu	2629	Page 1 of 1

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*	B	US-6,618,101 B1	09-2003	Kim et al.	349/54
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	J	US-			
	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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